


Search Notes 	Application/Control No. 10597856	Applicant(s)/Patent Under Reexamination LEE, KEUN-JIN
	Examiner Hal I Kaplan	Art Unit 2836

SEARCHED			
Class	Subclass	Date	Examiner
307	39	10/23/2008	HK

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	10/23/2008	HK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
Interference Search History Printout		10/23/2008	HK

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